B SHOULDER

规格书编号 SPEC NO:

产品规格书 SPECIFICATION

CUSTOMER 客户:		
PRODUCT 产品:	SAW FILTER	
MODEL NO 型 号:	HDBF14040A63 SF6-3	
PREPARED 编 制:	CHECKED 审核:	
APPROVED 批 准:	DATE 日 期:	2009-7-17

客户确认 CUSTOMER RECEIVED:		
审核 CHECKED	批准 APPROVED	日期 DATE

无锡市好达电子有限公司 Shoulder Electronics Limited



更改历史记录 History Record

更改日期 Date	规格书编号 Spec. No.	产品型号 Part No.	客户产品型号 Customer No.	更改内容描述 Modify Content	备注 Remark

HDBF14040A63 SF6-3

SAW FILTER

1. SCOPE

This specification shall cover the characteristics of SAW filter BF14040A63

2. ELECTRICAL SPECIFICATION

DC Voltage VDC	10V
AC Voltage Vpp	10V50Hz/60Hz
Operation temperature	-40°℃ to +85°℃
Storage temperature	-45°℃ to +85°℃
RF Power Dissipation	10dBm

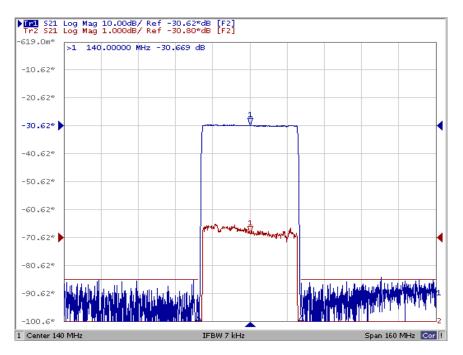
2.2 Electronic Characteristics

Parameter	Min	Тур	Max	Units
Center Frequency	139.75	140	140.25	MHz
Insertion Loss	-	30.5	34	dB
-1.0dB Bandwidth	40	40.5		MHz
-3.0dB Bandwidth	40.7	41.1		MHz
-35dB Bandwidth	-	42.5	42.8	MHz
-45dB Bandwidth	-	42.6	42.9	MHz
-55dB Bandwidth	-	64.8	64.9	MHz
Passband Variation	-	0.8	1.2	dB
Absolute Delay		2.5	2.6	usec
Group Delay Variation	-	30	-	nsec
Ultimate Rejection	-	55		dB
Material Temperature coef		-12.46		KHz/°C
Ambient Temperature		25		°C

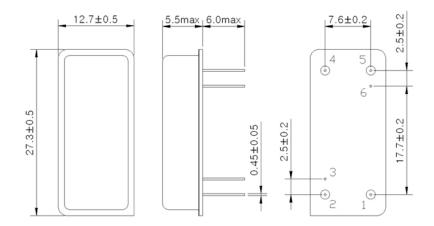


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2.3 Typical frequency response



3. DIMENSION



Pin Configuration	
1	Input
5	Output
2, 4	Ground
Other	Case ground

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4.TEST CIRCUIT



5. ENVIRONMENTAL CHARACTERISTICS

5-1 High temperature exposure

Subject the device to $+85^{\circ}$ C for 16 hours. Then release the filter into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in 2.2.

5-2 Low temperature exposure

Subject the device to -40° C for 16 hours. Then release the device into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in 2.2.

5-3 Temperature cycling

Subject the device to a low temperature of -40° C for 30 minutes. Following by a high temperature of $+85^{\circ}$ C for 30 Minutes. Then release the device into the room conditions for 24 hours prior to the measurement. It shall meet the specifications in 2.2.

5-4 Resistance to solder heat

Dip the device terminals no closer than 1.5mm into the solder bath at $260^{\circ}C \pm 10^{\circ}C$ for 10 ± 1 sec. Then release the device into the room conditions for 4 hours. The device shall meet the specifications in 2.2.

5-5 Solderability

Subject the device terminals into the solder bath at 245° C $\pm 5^{\circ}$ C for 5s, More than 95% area of the terminals must be covered with new solder. It shall meet the specifications in 2.2.

5-6 Mechanical shock

Drop the device randomly onto the concrete floor from the height of 1m 3 times. the device shall fulfill the specifications in 2.2.

5-7 Vibration

Subject the device to the vibration for 1 hour each in x,y and z axes with the amplitude of 1.5 mm at 10 to 55 Hz. The device shall fulfill the specifications in 2.2.



6. REMARK

6.1 Static voltage

Static voltage between signal load & ground may cause deterioration & destruction of the component. Please avoid static voltage.

6.2 Ultrasonic cleaning

Ultrasonic vibration may cause deterioration & destruction of the component. Please avoid ultrasonic cleaning

6.3 Soldering

Only leads of component may be soldered. Please avoid soldering another part of component